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ATTORNEY DOCKET NO. CONFIRMATION NO. FILING DATE FIRST NAMED INVENTOR APPLICATION NO M-8821 US 2593 09 628,116 07 28 2000 Roman Šobolewski 24251 05/14/2003 SKJERVEN MORRILL LLP EXAMINER 25 METRO DRIVE MORAN, TIMOTHY J SUITE 700 SAN JOSE, CA 95110 PAPER NUMBER ART UNIT

> 2878 DATE MAILED: 05-14-2003

Please find below and/or attached an Office communication concerning this application or proceeding.

•		Application No.	Applicant(s)	
		09'628 116	SOBOLEWSKI ET AL	
	Office Action Summary	Examiner	Art Unit	
		Timothy J. Moran	2878	
Period fo	The MAILING DATE of this communicator Reply	tion appears on the cover shee	with the correspondence address	
THE Leave after after a fill of the control of the	ORTENED STATUTORY PERIOD FOR MAILING DATE OF THIS COMMUNICA his ons of time may be awarded under the crows ons of 3 SIX & MONTHS from the mailing date of this communication of the crisis specified above the maximum statutore to reply within the set or extended period for reply within the set or extended period for reply within the set or extended period for reply with property of the Office later than three months afformed patent term adjustment. See 37 CFR 1704(b)	TION  OFF miss a consequent nowever ma at on  As a declination the statutor, minimum of r, per od will apply and will expire Six 6. If by statute cause the application to become	natied , bettmel, tied mint, 30 da,s will be considered timel, 10NTHS from the nating date of this communication a ABANDONED 135 U.S.C.§ 133	
Status				
1)	Responsive to communication(s) filed		<u>arch 2003</u> .	
2a) 🗌	·	This action is non-final.		
3) Disposit	Since this application is in condition fo closed in accordance with the practice ion of Claims			3
4)[	Claim(s) 1-24 is/are pending in the app	olication		
	4a) Of the above claim(s) is/are v	withdrawn from consideration		
5)	Claim(s) is/are allowed			
6)	Claim(s) <u>1-24</u> is/are rejected			
7)	Claim(s) is/are objected to			
8)[_]	Claim(s) are subject to restriction	n and/or election requirement		
Applicat	ion Papers			
9)	The specification is objected to by the E	xaminer		
10)	The drawing(s) filed on is/are: a)(	accepted or b) objected to b	y the Examiner	
	Applicant may not request that any objecti	ion to the drawing(s) be held in al	eyance. See 37 CFR 1.85(a).	
11)	The proposed drawing correction filed or	n is: a)	disapproved by the Examiner.	
	If approved, corrected drawings are requir	red in reply to this Office action		
12)	The oath or declaration is objected to by	the Examiner.		
Priority (	under 35 U.S.C. §§ 119 and 120			
13)	Acknowledgment is made of a claim for	r foreign priority under 35 U S	C § 119(a)-(d) or (f)	
a)	☐ All bi☐ Some * ci☐ None of			
	1 Certified copies of the priority do	cuments have been received		
	2 Certified copies of the priority does	cuments have been received i	n Application No	
* (	3  Copies of the certified copies of t application from the Internation See the attached detailed Office action for	onal Bureau (PCT Rule 17 2(a	))	
14) 🗍 /	Acknowledgment is made of a claim for o	domestic priority under 35 U S	C § 119(e) (to a provisional application	on).
	a)  The translation of the foreign langue Acknowledgment is made of a claim for			
Attachmer		domestic priority under 33 0 3	O 33 120 and/01 121.	
1) Note	ne of References Cited (PTO-892) ce of Draftsperson's Patent Drawing Review (PTO mation Disclosure Statement's ("PTO-1449) Pape	948) 5: Netice	ew Summary (PTO 413) Paper Nois) of Informal Patent Application (PTO 152)	
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Application/Control Number: 09/628.116

Art Unit: 2878

### **DETAILED ACTION**

### Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114. including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on March 31, 2003 has been entered.

#### Information Disclosure Statement

The information disclosure statement filed March 31, 2003 fails to comply with 37 CFR 1.98(a)(2), which requires a legible copy of each U.S. and foreign patent; each publication or that portion which caused it to be listed; and all other information or that portion which caused it to be listed. It has been placed in the application file, but the missing document (Kadin and Johnson) referred to therein has not been considered.

## Claim Rejections - 35 USC § 112

The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

Claims 20, 21, and 24 are rejected under 35 U.S.C. 112 first paragraph, as containing subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention. The limitation "at

least one switching transistor" is not described in the original specification or drawings. In addition, it is not clear how a "switching transistor" produces "light emissions." Note that claims 20, 21, and 24 have not been further treated on merits.

# Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title. If the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the mariner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e). (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 1-13 and 16-19 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hoyle. U. S. Patent No. 4.037.102 in view of Il'in, "Ultimate quantum efficiency of a superconducting hot-electron photodetector." Regarding claim 1, Hoyle teaches a method of detecting photons (col. 9, lines 32-34), comprising the acts of providing a superconductor strip (fig. 8, element 98, col. 8, lines 50-52) maintained below its critical temperature (col. 6, lines 12-18 teaches that the strip is in the

Application/Control Number: 09/628.116

Art Unit: 2878

superconducting state), electrically biasing said superconductor strip (col. 10, lines 12-24), directing light onto said biased superconductor strip (col. 9, lines 32-34), wherein said biasing is at a level near said superconductor strip's critical current (col. 6. lines 8-19) to enable detection of very small energy amounts. Hoyle does not explicitly teach the use of this method for the detection of single photons, but one skilled in the art of light detectors would recognize the advantage of a detector with a sensitivity high enough to detect single photons. Hoyle does teach that strips with small widths are sensitive to lower energy impacts (col. 6. lines 19-37 and lines 42-46, and col. 9. lines 12-34, fig. 10). In addition, Il'in teaches that the detection of single photons by superconducting strip detectors has a reasonable chance of success. Thus, one skilled in the art would therefore understand that by properly decreasing the width of the channel (or strip), the detection of single photons has a reasonable chance of success. Therefore it would have been obvious to one of ordinary skill in the art to provide for the detection of a single photon in the method of Hoyle. Regarding the limitation "time resolving said light directed unto said biased superconducting strip," Hoyle describes the detection of switching from normal to superconducting states (col. 2, lines 5-9). which implies that the time resolving of light is an inherent part of the method.

Regarding claim 2. Hoyle discusses the output pulse from the superconductor strip (col. 6. lines 33-42).

Regarding claim 3, niobium nitride is well known in the art as a superconductor material useful in detectors. Therefore, absent a showing of criticality, it would have

Application/Control Number. 09/628.116

Art Unit: 2878

been obvious to one of ordinary skill in the art to provide for a superconductor strip of niobium nitride in the modified method of Hoyle.

Regarding claim 4. Hoyle teaches the use of lasers and equivalent sources of energy may be used with the detector method. The use of superconductor materials to detect infrared radiation is well known in the art. Therefore it would have been obvious to one of ordinary skill in the art to provide a single photon with a wavelength between the visible and the far infrared spectral regions in the modified method of Hoyle

Regarding claim 5. Hoyle (fig. 9) teaches the use of a superconductor strip which defines a meander.

Regarding claim 6. Hoyle teaches the use of a strip with a width generally greater than or equal to 1 micron (col. 5, lines 35-41). However, Hoyle also teaches the advantage of using smaller widths with the advantage of the ability to detect smaller amounts of radiation (col. 9, lines 12-34, fig. 10). Therefore, it would have been obvious to one of ordinary skill in the art to provide for a superconductor strip with a width equal to or less than about 200 nm in the modified method of Hoyle.

Regarding claim 7. as described above. Hoyle describes a photon detector comprising a superconductor film coupled to a bias source, where said superconductor film is in the superconducting state and biased near its critical current. Hoyle also teaches the advantage of using strips with small widths, which would indicate to one of ordinary skill in the art the likelihood of success of this method for the purpose of detecting single photons. Therefore it would have been obvious to one of ordinary skill in the art to provide for a superconducting film dimension which allows detection of a

Application/Control Number: 09/628.116

Art Unit: 2878

single incident photon in the device of Hoyle. Regarding the limitation "a time measuring device ... to time resolve the detection." Hoyle describes the detection of switching from normal to superconducting states (col. 2. lines 5-9), which implies that the device comprises a time measuring device.

Regarding claim 8, niobium nitride is well known in the art as a superconductor material useful in detectors. Therefore, absent a showing of criticality, it would have been obvious to one of ordinary skill in the art to provide for a superconductor strip of niobium nitride in the modified device of Hoyle.

Regarding claim 9. Hoyle teaches the use of a strip with a width generally greater than or equal to 1 micron (col. 5. lines 35-41). However, Hoyle also teaches the advantage of using smaller widths (col. 9. lines 12-34, fig. 10). Therefore, it would have been obvious to one of ordinary skill in the art to provide for a superconductor strip with a width equal to or less than about 200 nm in the modified device of Hoyle.

Regarding claim 10. Hoyle teaches the formation of a detectable resistive region upon absorption of an incident photon onto the superconducting film (col. 6, lines 8-37).

Regarding claim 11, Hoyle teaches (fig. 3, element 50 and neighboring film portions, col. 4, lines 18-35) the use of wires coupled to pads at the ends of the superconducting film (64), and the use of such wires (50) to connect to the biasing source (col. 4, lines 13-17).

Regarding claim 12. Hoyle (fig. 9) teaches the use of a superconductor strip which defines a meander.

Regarding claim 13. Hoyle does not teach the use of gold in the contact pads. but does teach the use of "other conventional methods of securing leads at superconductive temperatures" (col. 4. lines 31-35). Gold is well known in the art as a useful material for achieving electrical contact to thin films. Therefore it would have been obvious to one of ordinary skill in the art to provide contact pads which include gold in the modified device of Hoyle to achieve good electrical contact.

Regarding claims 16 and 18. Hoyle does not explicitly teach the method of producing an output pulse which has a voltage greater than 1 mV. However. Hoyle does teach the production of output pulses with voltage of approximately 0.1 mV. and gives guidance on methods of increasing the sensitivity of the method (col. 8, lines 28-30 and col. 9, lines 12-34). The increase of output signal from 0.1 mV to 1 mV is considered to be within the ability of one of ordinary skill in the art. Therefore it would have been obvious to one of ordinary skill in the art to provide for an output pulse having a voltage greater than 1 mV in the modified device of Hoyle for the advantage of a larger signal.

Regarding claims 17 and 19. Hoyle teaches (col. 6. lines 21-37) that the radiation creates a resistive region extending across the width of said superconductor strip

Claim 14 is rejected under 35 U.S.C. 103(a) as being unpatentable over Hoyle and II'in as applied to claim 7 above, and further in view of Bornstein. U. S. Patent 4,987,305. Hoyle does not teach the coupling of light to the superconducting film using an optical fiber. However, Bornstein (fig. 3, abstract and col. 5, lines 44-55) teaches the coupling of light to an infrared detector (15) using an optical fiber (17) with the advantage of greater freedom in placement of detectors relative to light sources (col. 4).

Art Unit: 2878

lines 3-10). Therefore it would have been obvious to one of ordinary skill in the art to provide for the coupling of light to the superconducting film using an optical fiber in the modified device of Hoyle for the advantage of greater freedom of structural design.

Claim 15 is rejected under 35 U S C. 103(a) as being unpatentable over Hoyle and Il'in as applied to claim 7 above, and further in view of Weirauch, U. S. Patent No. 5.828,068. Hoyle does not teach the coupling of light to the superconducting film through a hemispherical lens. However, Weirauch (fig. 3) teaches the coupling of light to an infrared detector (10) through a hemispherical lens (18) for the advantage of collecting light from a large range of angles (col. 4, lines 27-30). Therefore it would have been obvious to one of ordinary skill in the art to provide for the coupling of light to the superconducting film through a hemispherical lens in the modified device of Hoyle for the advantage of collecting infrared light from a wide range of angles.

Claims 22 and 23 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hoyle and Il'in as applied to claims 1 and 7 above, and further in view of Ghis, Appl. Phys. Lett. 63, 551 (1993). Hoyle does not describe the time resolving of light to at least one nanosecond. However, Ghis teaches (fig. 1) that a superconducting strip detector is capable (with proper electronics) of time resolving light to at least one nanosecond. Therefore it would have been obvious to one of ordinary skill in the art to provide the proper electronics to achieve the time resolving of light to one nanosecond in the method and detector of Hoyle for the advantage of obtaining timing information.

#### Response to Arguments

Art Unit: 2878

Applicant's arguments filed March 31, 2003 have been fully considered but they are not persuasive.

In response to applicant's argument (page 5, third paragraph) that there is no suggestion to combine the references since the Il'in reference teaches operation above the critical temperature while Hoyle teaches operation below the critical temperature. applicant is directed to Hoyle (col. 5. lines 3-6 and col. 6. lines 12-18). Hoyle teaches that the detecting element is to be maintained near, and below, its critical temperature in order to be effective for detecting photons. Applicant is also directed to Il'in (page 3939. col. 1, last paragraph, sentence starting with "Thus, our studied..." and page 3940, col. 2, sentence starting with "The above..."), which teaches that superconducting thin film radiation detectors operating in the superconducting transition temperature region are likely to be effective in detecting single photons. The temperature ranges taught by the Hoyle and Il'in references are considered to be very similar, and possibly even overlapping considering the uncertainty in the width of a "superconducting transition region," and the understanding the a "superconducting transition region" typically comprises regions above and below a labeled a "critical temperature." Therefore, one skilled in the art and in possession of an understanding of the Hoyle reference would be led by the Il'in reference to conclude that a detector according to Hoyle would have a reasonable chance of success at detecting individual photons.

### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Timothy J. Moran whose telephone number is 703-305-0849. The examiner can normally be reached on M-F 8:30-5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Porta can be reached on 703-308-4852. The fax phone numbers for the organization where this application or proceeding is assigned are 703-872-9318 for regular communications and 703-872-9319 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.

T.M.

TM April 28, 2003 CONSTANTINE HANNAHER
PRIMARY EXAMINER

**GROUP ART UNIT 2878**